## Notice of References Cited Application/Control No. 10/645,894 Examiner Son V Nguyen Applicant(s)/Patent Under Reexamination TIEN, YUNG-CHENG Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	Α	US-6,394,827 B2	05-2002	Nogami, Daisuke	439/159
X	В	US-6,394,843 B1	05-2002	Chang et al.	439/607
X	С	US-6,478,591 B1	11-2002	Chang, Jen Jou	439/159
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
		US-			
	J	US-			
	К	US-			
	Ļ	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number	Date	Country	Nama	Classification
		Country Code-Number-Kind Code	MM-YYYY	Country	Name 	Classification
	- N					
	0					
	Р					
	Q					
	R					
	S					
	T					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.